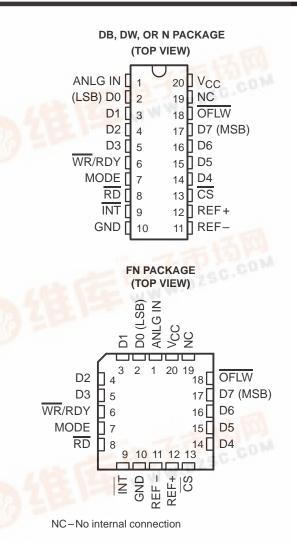
查询TLC0820ACDW供应商 基多邦,专业PCB打样工厂**TL400820AC**货TLC0820AI Advanced LinCMOS™ HIGH-SPEED 8-BIT ANALOG-TO-DIGITAL CONVERTERS USING MODIFIED FLASH TECHNIQUES SLAS064A - SEPTEMBER 1986 - REVISED JUNE 1994

- Advanced LinCMOS™ Silicon-Gate Technology
- 8-Bit Resolution
- Differential Reference Inputs
- Parallel Microprocessor Interface
- Conversion and Access Time Over Temperature Range Read Mode ... 2.5 μs Max
- No External Clock or Oscillator Components Required
- On-Chip Track and Hold
- Single 5-V Supply
- TLC0820A Is Direct Replacement for National Semiconductor ADC0820C/CC and Analog Devices AD7820K/B/T

description

The TLC0820AC and the TLC0820AI are Advanced LinCMOS[™] 8-bit analog-to-digital converters each consisting of two 4-bit flash converters, a 4-bit digital-to-analog converter, a summing (error) amplifier, control logic, and a result latch circuit. The modified flash technique allows low-power integrated circuitry to complete an 8-bit conversion in 1.18 µs over temperature. The on-chip track-and-hold circuit has a 100-ns sample window and allows these devices to convert continuous analog signals having slew rates of up to 100 mV/µs without external sampling components. TTL-compatible 3-state output drivers and two modes of operation allow



interfacing to a variety of microprocessors. Detailed information on interfacing to most popular microprocessors is readily available from the factory.

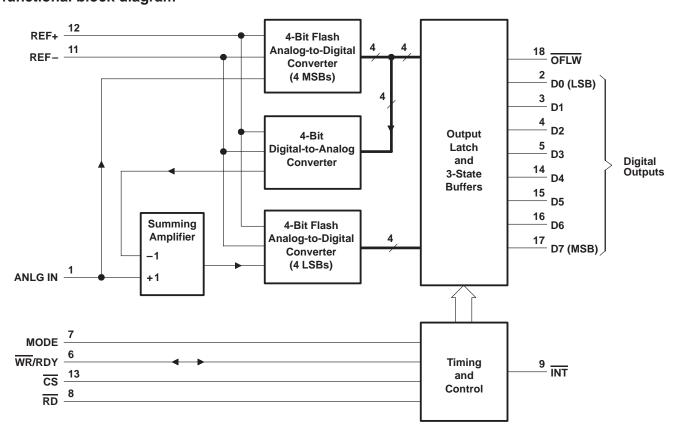
| AVAILABLE OPTIONS | | | | | | | | | |
|-------------------|------------|--------------|----------------------------------|---------------------------------|--------------------|--|--|--|--|
| | TOTAL | PACKAGE | | | | | | | |
| Τ _Α | UNADJUSTED | SSOP (DB) | PLASTIC SMALL OUTLINE (DW) | PLASTIC CHIP CARRIER (FN) | PLASTIC DIP (N) | | | | |
| 0°C to 70°C | ±1 LSB | TLC0820ACDB | TLC0820ACDW | TLC0820ACFN | TLC0820ACN | | | | |
| -40°C to 85°C | ±1 LSB | 12112 | TLC0820AIDW | TLC0820AIFN | TLC0820AIN | | | | |

Advanced LinCMOS is a trademark of Texas Instruments Incorporated.



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functional block diagram





TLC0820AC, TLC0820AI Advanced LinCMOSTM HIGH-SPEED 8-BIT ANALOG-TO-DIGITAL CONVERTERS USING MODIFIED FLASH TECHNIQUES SLAS064A – SEPTEMBER 1986 – REVISED JUNE 1994

| Terminal Functions | | | | | | | |
|--------------------|-----|-----|---|--|--|--|--|
| TERMIN | NAL | 1/0 | DESCRIPTION | | | | |
| NAME | NO. | 10 | | | | | |
| ANLG IN | 1 | I | Analog input | | | | |
| CS | 13 | I | Chip select. CS must be low in order for RD or WR to be recognized by the ADC. | | | | |
| D0 | 2 | 0 | Digital, 3-state output data, bit 1 (LSB) | | | | |
| D1 | 3 | 0 | Digital, 3-state output data, bit 2 | | | | |
| D2 | 4 | 0 | Digital, 3-state output data, bit 3 | | | | |
| D3 | 5 | 0 | Digital, 3-state output data, bit 4 | | | | |
| D4 | 14 | 0 | Digital, 3-state output data, bit 5 | | | | |
| D5 | 15 | 0 | Digital, 3-state output data, bit 6 | | | | |
| D6 | 16 | 0 | Digital, 3-state output data, bit 7 | | | | |
| D7 | 17 | 0 | Digital, 3-state output data, bit 8 (MSB) | | | | |
| GND | 10 | | Ground | | | | |
| ÎNT | 9 | 0 | Interrupt. In the write-read mode, the interrupt output (\overline{INT}) going low indicates that the internal count-down delay time, $t_{d(int)}$, is complete and the data result is in the output latch. The delay time $t_{d(int)}$ is typically 800 ns starting after the rising edge of WR (see operating characteristics and Figure 3). If RD goes low prior to the end of $t_{d(int)}$, \overline{INT} goes low at the end of $t_{d(RIL)}$ and the conversion results are available sooner (see Figure 2). INT is reset by the rising edge of either RD or CS. | | | | |
| MODE | 7 | I | Mode select. MODE is internally tied to GND through a 50-µA current source, which acts like a pulldown resistor. When MODE is low, the read mode is selected. When MODE is high, the write-read mode is selected. | | | | |
| NC | 19 | | No internal connection | | | | |
| OFLW | 18 | 0 | Overflow. Normally OFLW is a logical high. However, if the analog input is higher than V _{ref+} , OFLW will be low at the end of conversion. It can be used to cascade two or more devices to improve resolution (9 or 10 bits). | | | | |
| RD | 8 | I | Read. In the write-read mode with \overline{CS} low, the 3-state data outputs D0 through D7 are activated when \overline{RD} goes low. \overline{RD} can also be used to increase the conversion speed by reading data prior to the end of the internal count-down delay time. As a result, the data transferred to the output latch is latched after the falling edge of \overline{RD} . In the read mode with \overline{CS} low, the conversion starts with \overline{RD} going low. \overline{RD} also enables the 3-state data outputs on completion of the conversion. RDY going into the high-impedance state and \overline{INT} going low indicate completion of the conversion. | | | | |
| REF- | 11 | I | Reference voltage. REF - is placed on the bottom of the resistor ladder. | | | | |
| REF+ | 12 | I | Reference voltage. REF + is placed on the top of the resistor ladder. | | | | |
| VCC | 20 | | Power supply voltage | | | | |
| WR/RDY | 6 | I/O | Write ready. In the write-read mode with \overline{CS} low, the conversion is started on the falling edge of the \overline{WR} input signal. The result of the conversion is strobed into the output latch after the internal count-down delay time, $t_{d(int)}$, provided that the RD input does not go low prior to this time. The delay time $t_{d(int)}$ is approximately 800 ns. In the read mode, RDY (an open-drain output) goes low after the falling edge of \overline{CS} and goes into the high-impedance state when the conversion is strobed into the output latch. It is used to simplify the interface to a microprocessor system. | | | | |



TLC0820AC, TLC0820AI Advanced LinCMOS[™] HIGH-SPEED 8-BIT ANALOG-TO-DIGITAL CONVERTERS USING MODIFIED FLASH TECHNIQUES

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| Supply voltage, V _{CC} (see Note 1) | 10 V |
|---|----------------------------------|
| Input voltage range, all inputs (see Note 1) | –0.2 V to V _{CC} +0.2 V |
| Output voltage range, all outputs (see Note 1) | -0.2 V to V _{CC} +0.2 V |
| Operating free-air temperature range: TLC0820AC | 0°C to 70°C |
| TLC0820AI | \dots -40°C to 85°C |
| Storage temperature range | −65°C to 150°C |
| Case temperature for 10 seconds: FN package | 260°C |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: DB, DW or N package | 260°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltages are with respect to network GND.

recommended operating conditions

| | | | MIN | NOM | MAX | UNIT | |
|---|---|----------------|-----|---|----------------------|------|--|
| Supply voltage, V _{CC} | | | | $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | | | |
| Analog input voltage | | | | | V _{CC} +0.1 | V | |
| Positive reference voltage, V _{ref+} | | | | | VCC | V | |
| Negative reference voltage, V _{ref} _ | | | | | V _{ref+} | V | |
| High-level input voltage, VIH | 1/22 - 4.75 / 125 - 25 / 125 - | CS, WR/RDY, RD | 2 | | | V | |
| Thigh-level input voltage, vIH | VCC = 4.75 V 10 5.25 V | MODE | 3.5 | | | v | |
| Low-level input voltage, VII | | CS, WR/RDY, RD | | | 0.8 | V | |
| | VCC = 4.75 V 10 5.25 V | MODE | | | 1.5 | v | |
| Pulse duration, write in write-read mode, $t_{W(W)}$ (see | 0.5 | | 50 | μs | | | |
| Operating free air temperature T | TLC0820AC | | 0 | | 70 | °C | |
| Operating free-air temperature, T _A | TLC0820AI | -40 | | 85 | C | | |

TLC0820AC, TLC0820AI Advanced LinCMOSTM HIGH-SPEED 8-BIT ANALOG-TO-DIGITAL CONVERTERS USING MODIFIED FLASH TECHNIQUES SLAS064A – SEPTEMBER 1986 – REVISED JUNE 1994

| electrical characteristics at specified operating free-air temperature, V _{CC} = 5 V (unless otherwise |
|---|
| noted) |

| PARAMETER | | | TEST CONDITIONS | T _A † | MIN | TYP | MAX | UNIT | |
|---------------------------------------|--|-----------------------------|--|------------------|-------|--------|------|------|--|
| VOH | | D0–D7, INT, or | V _{CC} = 4.75 V, I _{OH} = -360 μA | Full range | 2.4 | | | | |
| | High-level output voltage | OFLW | V _{CC} = 4.75 V, | Full range | 4.5 | | | V | |
| | | | I _{OH} = -10 μA | 25°C | 4.6 | | | | |
| VOL | Low-level output voltage | D0–D7, OFLW, INT, or WR/RDY | V _{CC} = 5.25 V, I _{OL} = 1.6 mA | Full range | | | 0.4 | v | |
| VOL | Low-level output voltage | | | 25°C | | | 0.34 | | |
| | | CS or RD | | Full range | | 0.005 | 1 | | |
| | | WR/RDY |] | Full range | | | 3 | | |
| Iн | High-level input current | | V _{IH} = 5 V | 25°C | | 0.1 | 0.3 | μΑ | |
| | | MODE |] | Full range | | | 200 | | |
| | | MODE | | 25°C | | 50 | 170 | | |
| ۱ | Low-level input current | CS, WR/RDY, RD, or MODE | V _{IL} = 0 | Full range | | -0.005 | -1 | μA | |
| | Off-state (high-impedance-state) output current | D0-D7 or WR/RDY | V _O = 5 V | Full range | | | 3 | μA | |
| | | | | 25°C | | 0.1 | 0.3 | | |
| loz | | | V _O = 0 | Full range | | | -3 | | |
| | | | | 25°C | | -0.1 | -0.3 | | |
| | | | CS at 5 V, $V_I = 5 V$ | Full range | | | 3 | μA | |
| 1. | | | | 25°C | | | 0.3 | | |
| II. | Analog input current | | | Full range | | | -3 | | |
| | | | CS at 5 V, $V_{I} = 0$ | 25°C | | | -0.3 | | |
| | Short-circuit output current | D0–D7, OFLW, INT, or WR/RDY | V _O = 5 V | Full range | 7 | | | mA | |
| | | | | 25°C | 8.4 | 14 | | | |
| 100 | | D0-D7 or OFLW | - V _O = 0 | Full range | -6 | | | | |
| los | | | | 25°C | -7.2 | -12 | | | |
| | | INT | | Full range | -4.5 | | | | |
| | | | | 25°C | - 5.3 | -9 | | | |
| p . | Reference resistance | | | Full range | 1.25 | | 6 | | |
| R _{ref} Reference resistance | | | | 25°C | 1.4 | 2.3 | 5.3 | kΩ | |
| | Querra ha comment | | CS, WR/RDY, and | Full range | | | 15 | | |
| lcc | Supply current | | RD at 0 V | 25°C | | 7.5 | 13 | mA | |
| <u> </u> | | D0-D7 | | Eull room | | 5 | | | |
| Ci | Input capacitance | ANLG IN |] | Full range | | 45 | | pF | |
| Co | Output capacitance | D0-D7 | | Full range | | | 5 | pF | |

[†] Full range is as specified in recommended operating conditions.



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operating characteristics, $V_{CC} = 5 V$, $V_{ref+} = 5 V$, $V_{ref-} = 0$, $t_r = t_f = 20 ns$, $T_A = 25^{\circ}C$ (unless otherwise noted)

| | PARAMETER | TEST | CONDITIONS [†] | MIN TYP | MAX | UNIT | |
|----------------------|---|--|---|-----------------------------|-----------------------------|------|--|
| ksvs | Supply-voltage sensitivity | $V_{CC} = 5 V \pm 5\%,$ | $T_A = MIN \text{ to } MAX$ | ±1/16 | ±1/4 | LSB | |
| | Total unadjusted error‡ | MODE at 0 V, | $T_A = MIN$ to MAX | | 1 | LSB | |
| ^t conv(R) | Conversion time, read mode | MODE at 0 V, | See Figure 1 | 1.6 | 2.5 | μs | |
| ^t a(R) | Access time, $\overline{RD}\downarrow$ to data valid | MODE at 0 V, | See Figure 1 | ^t conv(R) +20 | ^t conv(R) +50 | ns | |
| | | MODE at 5 V, | C _L = 15 pF | 190 | 280 | | |
| ^t a(R1) | Access time, $\overline{RD}\downarrow$ to data valid | ^t d(WR) ^{< t} d(int), See Figure 2 | C _L = 100 pF | 210 | 320 | ns | |
| | | MODE at 5 V, | C _L = 15 pF | 70 | 120 | | |
| ^t a(R2) | Access time, $\overline{RD}\downarrow$ to data valid | ^t d(WR) > ^t d(int), See Figure 3 | C _L = 100 pF | 90 | 150 | ns | |
| ^t a(INT) | Access time, $\overline{INT}\downarrow$ to data valid | MODE at 5 V, | See Figure 4 | 20 | 50 | ns | |
| ^t dis | Disable time, \overline{RD} to data valid | $R_L = 1 k\Omega$, See Figures 1, 2, 3 | CL = 10 pF, 3, and 5 | 70 | 95 | ns | |
| ^t d(int) | Delay time, WR/RDY \uparrow to INT \downarrow | MODE at 5 V, See Figures 2, 3, a | CL = 50 pF, and 4 | 800 | 1300 | ns | |
| ^t d(NC) | Delay time, to next conversion | See Figures 1, 2, 3 | See Figures 1, 2, 3, and 4 | | | ns | |
| ^t d(WR) | Delay time, WR/RDY↑ to RD↓ in write-read mode | See Figure 2 | | 0.4 | | μs | |
| ^t d(RDY) | Delay time, CS \downarrow to WR/RDY \downarrow | MODE at 0 V, See Figure 1 | C _L = 50 pF, | 50 | 100 | ns | |
| ^t d(RIH) | Delay time, RD↑ to INT↑ | C _L = 50 pF, | See Figures 1, 2, and 3 | 125 | 225 | ns | |
| ^t d(RIL) | Delay time, RD \downarrow to INT \downarrow | MODE at 5 V, See Figure 2 | ^t d(WR) < ^t d(int), | 200 | 290 | ns | |
| ^t d(WIH) | Delay time, WR/RDY↑ to INT↑ | MODE at 5 V, See Figure 4 | C _L = 50 pF, | 175 | 270 | ns | |
| | Slew-rate tracking | | | 0.1 | | V/µs | |

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] Total unadjusted error includes offset, full-scale, and linearity errors.



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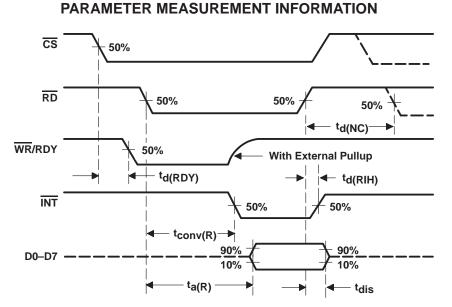
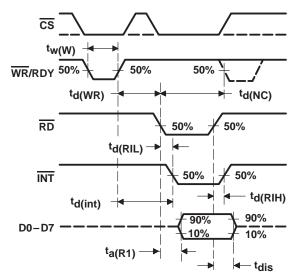
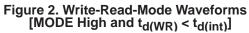
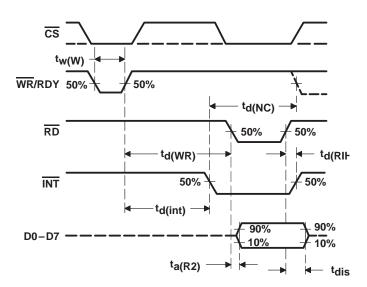
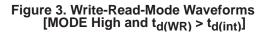


Figure 1. Read-Mode Waveforms (MODE Low)











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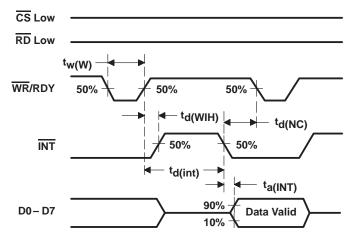
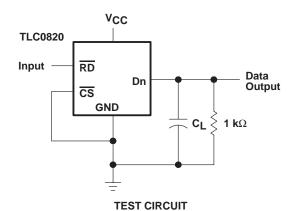
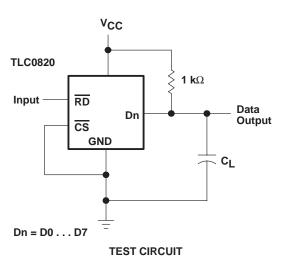
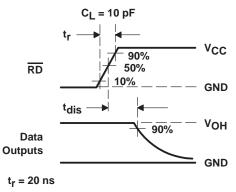


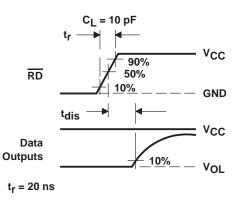
Figure 4. Write-Read-Mode Waveforms (Stand-Alone Operation, MODE High, and RD Low)



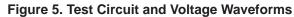








VOLTAGE WAVEFORMS





TLC0820AC, TLC0820AI Advanced LinCMOS[™] HIGH-SPEED 8-BIT ANALOG-TO-DIGITAL CONVERTERS USING MODIFIED FLASH TECHNIO

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PRINCIPLES OF OPERATION

The TLC0820AC and TLC0820AI each employ a combination of sampled-data comparator techniques and flash techniques common to many high-speed converters. Two 4-bit flash analog-to-digital conversions are used to give a full 8-bit output.

The recommended analog input voltage range for conversion is -0.1 V to V_{CC} + 0.1 V. Analog input signals that are less than V_{ref-} + 1/2 LSB or greater than V_{ref+} – 1/2 LSB convert to 00000000 or 11111111, respectively. The reference inputs are fully differential with common-mode limits defined by the supply rails. The reference input values define the full-scale range of the analog input. This allows the gain of the ADC to be varied for ratiometric conversion by changing the V_{ref+} and V_{ref-} voltages.

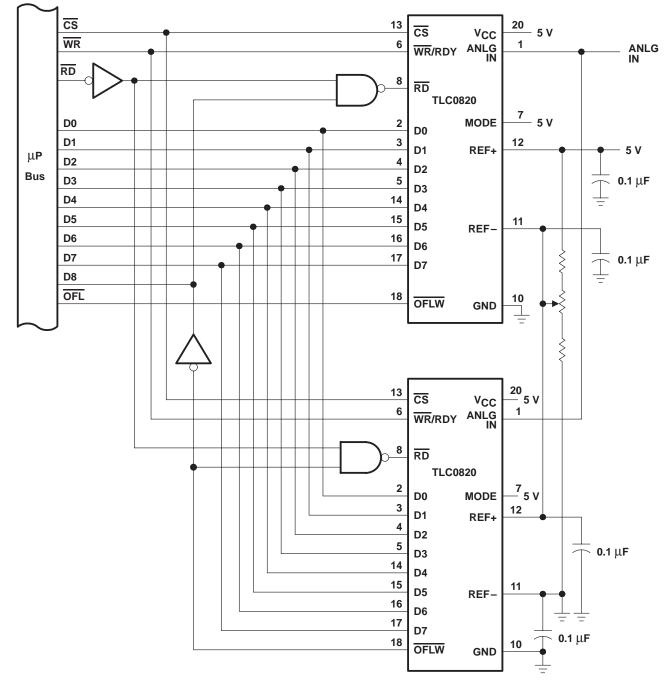
The device operates in two modes, read (only) and write-read, that are selected by MODE. The converter is set to the read (only) mode when MODE is low. In the read mode, WR/RDY is used as an output and is referred to as the ready terminal. In this mode, a low on \overline{WR}/RDY while \overline{CS} is low indicates that the device is busy. Conversion starts on the falling edge of RD and is completed no more than 2.5 us later when INT falls and WR/RDY returns to the high-impedance state. Data outputs also change from high-impedance to active states at this time. After the data is read, RD is taken high, INT returns high, and the data outputs return to their high-impedance states.

When MODE is high, the converter is set to the write-read mode and WR/RDY is referred to as the write terminal. Taking CS and WR/RDY low selects the converter and initiates measurement of the input signal. Approximately 600 ns after \overline{WR}/RDY returns high, the conversion is completed. Conversion starts on the rising edge of \overline{WR}/RDY in the write-read mode.

The high-order 4-bit flash ADC measures the input by means of 16 comparators operating simultaneously. A high-precision 4-bit DAC then generates a discrete analog voltage from the result of that conversion. After a time delay, a second bank of comparators does a low-order conversion on the analog difference between the input level and the high-order DAC output. The results from each of these conversions enter an 8-bit latch and are output to the 3-state output buffers on the falling edge of \overline{RD} .



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APPLICATION INFORMATION

Figure 6. Configuration for 9-Bit Resolution



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